Searcn Notes			

Application/Control No.	Applicant(s)/Patent un Reexamination	der
09/892,622	MIYAWAKI ET AL.	
Examiner	Art Unit	
Cong-Lac Huynh	2178	

Cong-Lac Huynh

SEARCHED				
Class	Subclass	Date	Examiner	
715	500	7/23/2006	CLH	
	501.1	7/23/2006	CLH	
	769	7/23/2006	CLH	
	770	7/23/2006	CLH	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEAF (INCLUDING S	RCH NOT)
		DATE	EXMR
East		7/23/2006	CLH
ACM		7/23/2006	CLH
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